

2SA1531, 2SA1531A

Silicon PNP epitaxial planar type

For low-frequency and low-noise amplification

Complementary to 2SC3929 and 2SC3929A

■ Features

- Low noise voltage NV
- High forward current transfer ratio h_{FE}
- S-Mini type package, allowing downsizing of the equipment and automatic insertion through the tape packing and the magazine packing

■ Absolute Maximum Ratings $T_a = 25^\circ\text{C}$

Parameter	Symbol	Rating	Unit
Collector-base voltage (Emitter open)	V_{CBO}	-35	V
	2SA1531A	-55	
Collector-emitter voltage (Base open)	V_{CEO}	-35	V
	2SA1531A	-55	
Emitter-base voltage (Collector open)	V_{EBO}	-5	V
Collector current	I_C	-50	mA
Peak collector current	I_{CP}	-100	mA
Collector power dissipation	P_C	150	mW
Junction temperature	T_j	150	$^\circ\text{C}$
Storage temperature	T_{stg}	-55 to +150	$^\circ\text{C}$

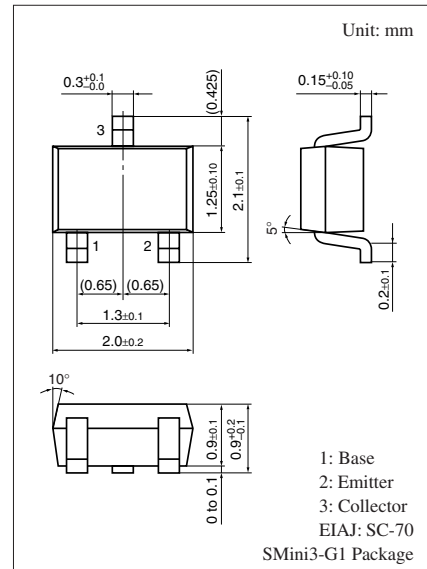
■ Electrical Characteristics $T_a = 25^\circ\text{C} \pm 3^\circ\text{C}$

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Collector-base voltage (Emitter open)	V_{CBO}	$I_C = -10 \mu\text{A}, I_E = 0$	-35			V
	2SA1531A		-55			
Collector-emitter voltage (Base open)	V_{CEO}	$I_C = -2 \text{mA}, I_B = 0$	-35			V
	2SA1531A		-55			
Emitter-base voltage (Collector open)	V_{EBO}	$I_E = -10 \mu\text{A}, I_C = 0$	-5			V
Base-emitter voltage	V_{BE}	$V_{CE} = -1 \text{V}, I_C = -100 \text{mA}$		-0.7	-1.0	V
Collector-base cutoff current (Emitter open)	I_{CBO}	$V_{CB} = -10 \text{V}, I_E = 0$			-0.1	μA
Collector-emitter cutoff current (Base open)	I_{CEO}	$V_{CE} = -10 \text{V}, I_B = 0$			-1	μA
Forward current transfer ratio *	h_{FE}	$V_{CE} = -5 \text{V}, I_C = -2 \text{mA}$	180		700	—
Collector-emitter saturation voltage	$V_{CE(sat)}$	$I_C = -100 \text{mA}, I_B = -10 \text{mA}$			-0.6	V
Transition frequency	f_T	$V_{CB} = -5 \text{V}, I_E = 2 \text{mA}, f = 200 \text{MHz}$		150		MHz
Noise voltage	NV	$V_{CE} = -10 \text{V}, I_C = -1 \text{mA}, G_V = 80 \text{dB}$ $R_g = 100 \text{k}\Omega, \text{Function} = \text{FLAT}$			150	mV

Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

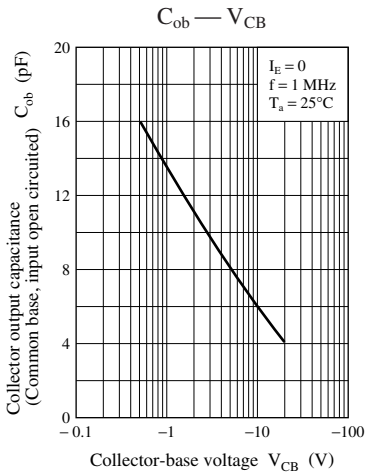
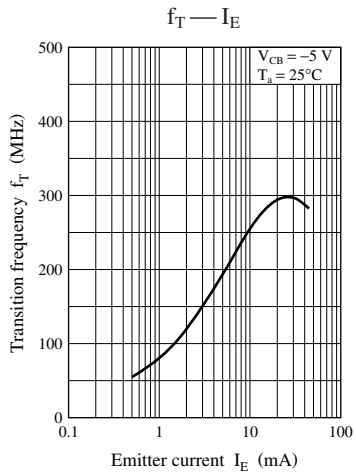
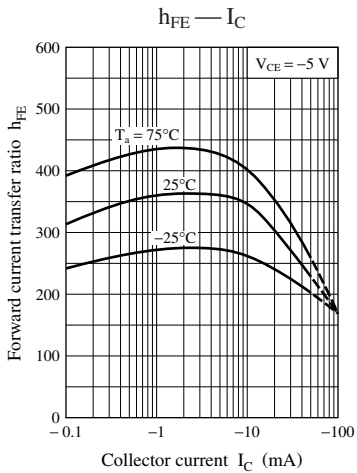
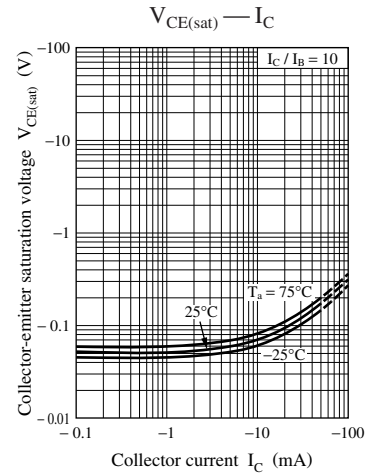
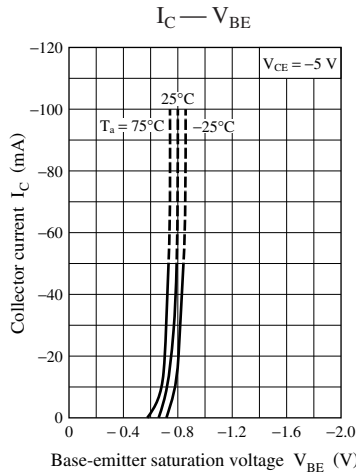
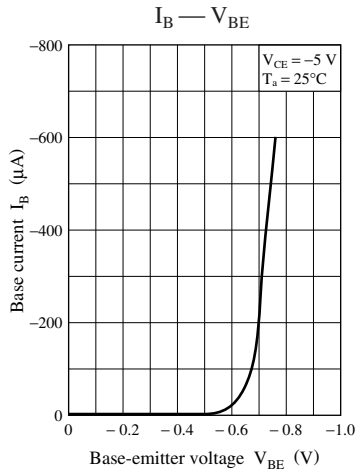
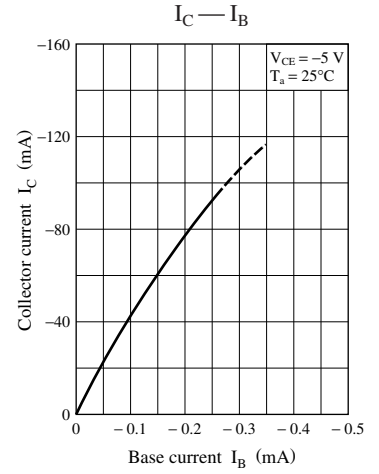
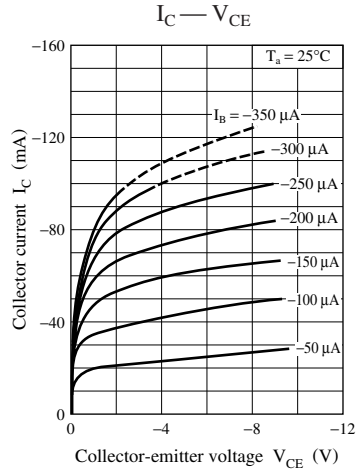
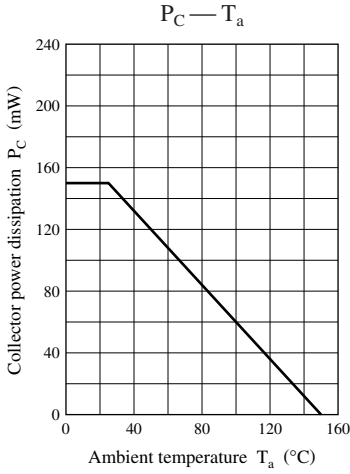
2. *: Rank classification

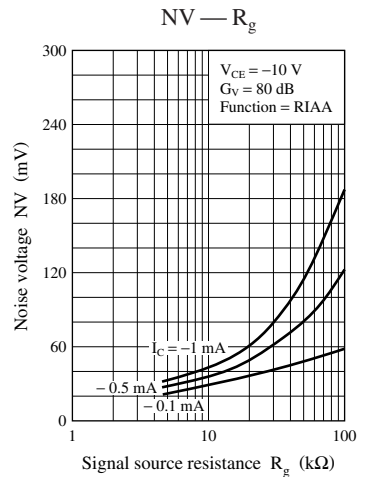
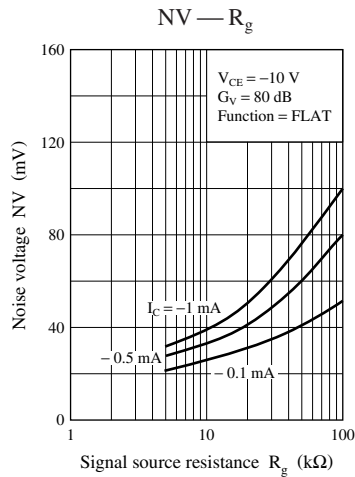
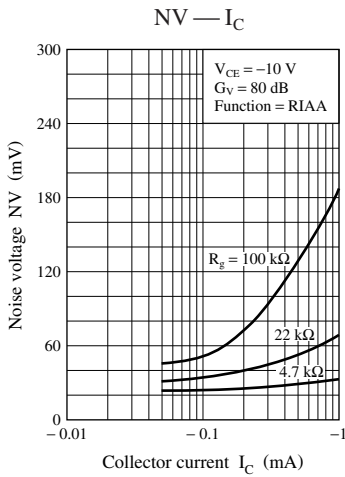
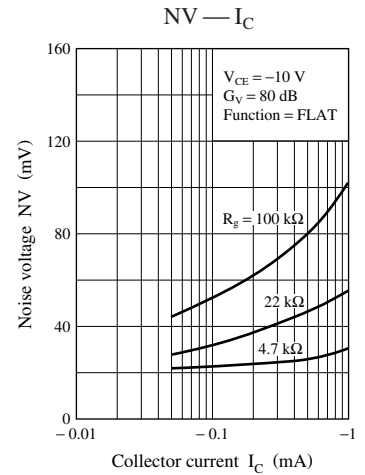
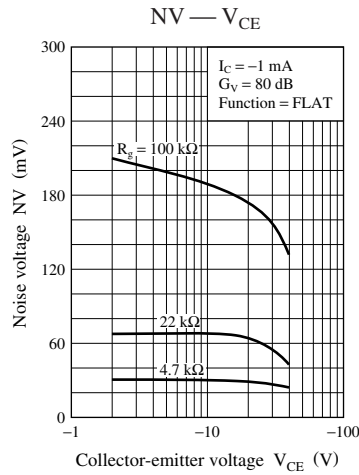
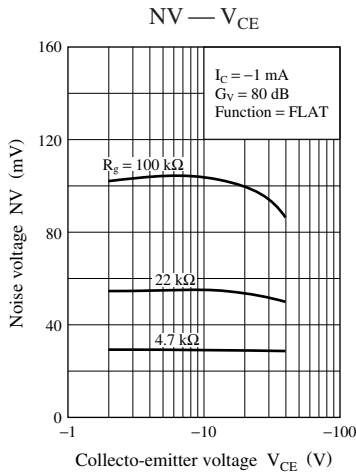
Rank	R	S	T
h_{FE}	180 to 360	260 to 520	360 to 700



Marking Symbol:

- 2SA1531: F
- 2SA1531A: H





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